TAI-TECH KBM01-200800339 P2

# **High Current Ferrite Chip Bead(Lead Free)**

HCB3216KF-301T20

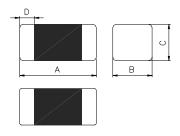
Certificate

Green Partner

#### 1.Features

- 1. Monolithic inorganic material construction.
- 2. Closed magnetic circuit avoids crosstalk.
- 3. Suitable for reflow soldering.
- 4. Shapes and dimensions follow E.I.A. spec.
- 5. Available in various sizes.
- 6. Excellent solder ability and heat resistance.
- 7. High reliability.
- 8. 100% Lead(Pb) & Halogen-Free and RoHS compliant.
- 9. Low DC resistance structure of electrode to prevent wasteful electric power consumption.
- 10. Operating Temperature: -55~+125 $^{\circ}$ C (Including self-temperature rise)

#### 2.Dimensions



| Chip Size |           |  |  |  |  |
|-----------|-----------|--|--|--|--|
| Α         | 3.20±0.20 |  |  |  |  |
| В         | 1.60±0.20 |  |  |  |  |
| С         | 1.10±0.20 |  |  |  |  |
| D         | 0.50±0.30 |  |  |  |  |

Units: mm

### 3.Part Numbering



B: Dimension

LxW

C: Material

Lead Free Material **301=300** Ω

D: Impedance E: Packaging

T=Taping and Reel, B=Bulk(Bags)

F: Rated Current 20=2000mA

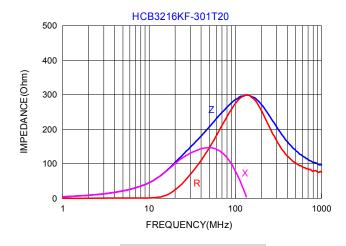
### Termination (Pb Free) Ag(100%) Ni(100%)-1.5um (min.) Sn(100%)-3.5um (min.) Ferrite Body (Pb Free)

#### 4. Specification

| Tai-Tech<br>Part Number | Impedance ( $\Omega$ ) | Test Frequency<br>(Hz) | DC Resistance $(\Omega)$ max. | Rated Current (mA) max. |
|-------------------------|------------------------|------------------------|-------------------------------|-------------------------|
| HCB3216KF-301T20        | 300±25%                | 60mV/100M              | 0.10                          | 2000                    |

- Rated current: based on temperature rise test
- In compliance with EIA 595

#### Impedance-Frequency Characteristics



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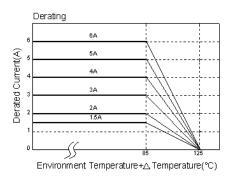
### 5. Reliability and Test Condition

| Item                                  |                                              |                                                                                                                                                                                                              | Performance                     | е                 |                      |                                                                                                                                                                                                                               | Te                                                                                                                                                                                                                                                                                                                                               | st Cond                                                                                                                                                                                                                                                                           | dition                                   |                          |
|---------------------------------------|----------------------------------------------|--------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|---------------------------------|-------------------|----------------------|-------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|--------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|-----------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|------------------------------------------|--------------------------|
| Series No.                            | FCB                                          | FCM                                                                                                                                                                                                          | HCB                             | GHB               | FCA                  |                                                                                                                                                                                                                               |                                                                                                                                                                                                                                                                                                                                                  |                                                                                                                                                                                                                                                                                   |                                          |                          |
| Operating Temperature                 |                                              | (Includi                                                                                                                                                                                                     | -55~+125℃<br>ing self-tempera   | ture rise)        |                      |                                                                                                                                                                                                                               |                                                                                                                                                                                                                                                                                                                                                  |                                                                                                                                                                                                                                                                                   |                                          |                          |
| Transportation<br>Storage Temperature |                                              |                                                                                                                                                                                                              | -55~+125℃<br>(on board)         |                   |                      | For long                                                                                                                                                                                                                      |                                                                                                                                                                                                                                                                                                                                                  |                                                                                                                                                                                                                                                                                   | ons, please                              | see the                  |
| Impedance (Z)                         | Pofor to stan                                | dard electrical ch                                                                                                                                                                                           | aractoristics list              |                   |                      | Agilent42<br>Agilent E<br>Agilent42<br>Agilent16                                                                                                                                                                              | 4991<br>287                                                                                                                                                                                                                                                                                                                                      |                                                                                                                                                                                                                                                                                   |                                          |                          |
| DC Resistance                         | _ Relei to stall                             | Jaiu electrical cri                                                                                                                                                                                          | aracteristics list              |                   |                      | Agilent 4                                                                                                                                                                                                                     |                                                                                                                                                                                                                                                                                                                                                  |                                                                                                                                                                                                                                                                                   |                                          |                          |
| Rated Current                         |                                              |                                                                                                                                                                                                              |                                 |                   |                      | DC Power<br>Over Rat<br>some risk                                                                                                                                                                                             | ed Curr                                                                                                                                                                                                                                                                                                                                          |                                                                                                                                                                                                                                                                                   | ements, the                              | re will be               |
| Temperature Rise Test                 |                                              | 1A ΔT 20℃Max<br>= 1A ΔT 40℃Max                                                                                                                                                                               |                                 | 2. Tempe<br>therm | erature r<br>ometer. |                                                                                                                                                                                                                               | by digital su                                                                                                                                                                                                                                                                                                                                    |                                                                                                                                                                                                                                                                                   |                                          |                          |
| Life test                             |                                              | vithin±15%of initia                                                                                                                                                                                          |                                 |                   |                      | times.( IF<br>Reflow P<br>Tempera<br>Applied of<br>Duration:<br>Measure<br>for 24±2                                                                                                                                           | PC/JED<br>trofiles)<br>ture: 12<br>current:<br>: 1000±<br>d at ro<br>hrs.                                                                                                                                                                                                                                                                        | EC J-STD  5±2°C  rated curr  12hrs.  om tempe                                                                                                                                                                                                                                     | erature after                            | sification               |
| Load Humidity                         | Q : Shall not                                | Impedance: within±15% of initial value. Inductance: within±10% of initial value. Q: Shall not exceed the specification value. RDC: within ±15% of initial value and shall not exceed the specification value |                                 |                   |                      |                                                                                                                                                                                                                               |                                                                                                                                                                                                                                                                                                                                                  | Preconditioning: Run through IR reflow for 3 times. (IPC/JEDEC J-STD-020E Classification Reflow Profiles) Humidity: 85±2%R.H. Temperature: 85±2°C. Duration:1000hrsMin.Bead:with100%ratedcurr ent - Inductance: with 10% rated current Measured at room temperature after placing |                                          |                          |
| Thermal shock                         | Inductance: v<br>Q : Shall not               | no damage.<br>within±15%of initia<br>vithin±10%of initia<br>exceed the speci<br>±15% of initial va                                                                                                           | al value.<br>ification value.   | ot exceed the spe | ecification value    | Preconditimes.( If Reflow P Condition Step1: -5 Step2: 29 Step3: +' Number Measure                                                                                                                                            | for 24 $\pm$ 2 hrs. Preconditioning: Run through IR reflow for times. ( IPC/JEDEC J-STD-020E Classificati Reflow Profiles) Condition for 1 cycle Step1: $-55\pm2^{\circ}$ C 30 $\pm$ 5 min. Step2: $25\pm2^{\circ}$ C 30 $\pm$ 5 min. Step3: $+125\pm2^{\circ}$ C 30 $\pm$ 5 min. Number of cycles: 500 Measured at room temperature after placi |                                                                                                                                                                                                                                                                                   |                                          |                          |
| Vibration                             | Inductance :<br>Q : Shall not                | : No damage.<br>within±15% of ini<br>within±10% of ini<br>exceed the speci<br>±15% of initial va                                                                                                             | itial value<br>ification value. | ot exceed the spe | ecification value    | times.( IF<br>Reflow P<br>Oscillation<br>for 20 mi<br>Equipment<br>Total Am<br>Testing T                                                                                                                                      | for 24±2 hrs.  Preconditioning: Run through IR reflow fo times.( IPC/JEDEC J-STD-020E Classifical Reflow Profiles) Oscillation Frequency: 10Hz ~ 2KHz ~ 10 for 20 minutes Equipment: Vibration checker Total Amplitude:10g Testing Time: 12 hours(20 minutes, 12 cycleach of 3 orientations) °                                                   |                                                                                                                                                                                                                                                                                   |                                          | sification $z\sim 10$ Hz |
| Bending                               | Impedance :<br>Inductance :<br>Q : Shall not | : No damage.<br>within±10% of ini<br>within±10% of ini<br>exceed the speci<br>±15% of initial va                                                                                                             | itial value<br>ification value. | ot exceed the spe | ecification value    | Shall be mounted on a FR4 substrate of the following dimensions: >=0805inch(2012mm):40x100x1.2mm <0805inch(2012mm):40x100x0.8mm Bending depth: >=0805inch(2012mm):1.2mm <0805inch(2012mm):0.8mm Duration of 10 sec for a min. |                                                                                                                                                                                                                                                                                                                                                  |                                                                                                                                                                                                                                                                                   |                                          |                          |
|                                       |                                              | : No damage.                                                                                                                                                                                                 | Higher                          |                   |                      | Test co                                                                                                                                                                                                                       | Peak                                                                                                                                                                                                                                                                                                                                             | Normal                                                                                                                                                                                                                                                                            | We if                                    | Velocity                 |
| Shock                                 | Inductance :                                 | within±10% of ini                                                                                                                                                                                            | itial value                     |                   |                      | Туре                                                                                                                                                                                                                          | Value<br>(g's)                                                                                                                                                                                                                                                                                                                                   | duration<br>(D) (ms)                                                                                                                                                                                                                                                              | Wave form                                | change<br>(Vi)ft/sec     |
|                                       |                                              | exceed the speci<br>±15% of initial va                                                                                                                                                                       |                                 | ot exceed the spe | ecification value    | SMD                                                                                                                                                                                                                           | 50<br>50                                                                                                                                                                                                                                                                                                                                         | 11                                                                                                                                                                                                                                                                                | Half-sine<br>Half-sine                   | 11.3                     |
|                                       |                                              |                                                                                                                                                                                                              |                                 |                   |                      |                                                                                                                                                                                                                               |                                                                                                                                                                                                                                                                                                                                                  |                                                                                                                                                                                                                                                                                   |                                          |                          |
| Solderability                         | More than 959                                | % of the terminal                                                                                                                                                                                            | electrode shoul                 | d be covered with | n solder.            | @235°C:<br>b. Metho<br>± 15 min                                                                                                                                                                                               | ±5°C Te<br>d D cat<br>)@ 260°                                                                                                                                                                                                                                                                                                                    | est time:5 -                                                                                                                                                                                                                                                                      | @155°C d<br>+0/-0.5 seco<br>(steam aging | onds.                    |

| Item                    | Performance                                                                                                                                                                                                                      | Test Condition                                                                                                                                                                                                                                                                                                                                                               |
|-------------------------|----------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
|                         |                                                                                                                                                                                                                                  | Number of heat cycles: 1                                                                                                                                                                                                                                                                                                                                                     |
| Resistance to Soldering | Appearance: No damage. Impedance: within±15% of initial value                                                                                                                                                                    | Temperature (°C) Time (s) Temperature ramp/immersion and emersion rate                                                                                                                                                                                                                                                                                                       |
| Heat                    | Inductance: within±10% of initial value Q: Shall not exceed the specification value. RDC: within ±15% of initial value and shall not exceed the specification val                                                                | 260 ±5 (solder temp) 10 ±1 25mm/s ±6 mm/s                                                                                                                                                                                                                                                                                                                                    |
|                         |                                                                                                                                                                                                                                  | Depth: completely cover the termination                                                                                                                                                                                                                                                                                                                                      |
| Terminal strength       | Appearance: No damage. Impedance: within±15% of initial value Inductance: within±10% of initial value Q: Shall not exceed the specification value. RDC: within±15% of initial value and shall not exceed the specification value | Preconditioning: Run through IR reflow for 3 times.( IPC/JEDEC J-STD-020E Classification Reflow Profiles) Component mounted on a PCB apply a force >0805inch(2012mm):1kg <=0805inch(2012mm):0.5kg to the side of a device being tested. This force shall be applied for 60 +1 seconds. Also the force shall be applied gradually as not to shock the component being tested. |

#### \*\*Derating Curve

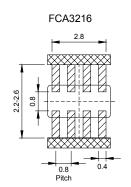
For the ferrite chip bead which withstanding current over 1.5A, as the operating temperature over  $85^{\circ}\mathrm{C}$ , the derating current information is necessary to consider with. For the detail derating of current, please refer to the Derated Current vs. Operating Temperature curve.



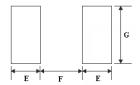
### 6. Soldering and Mounting

#### 6-1. Recommended PC Board Pattern

|        |                                   | Land Patterns For<br>Reflow Soldering |           |           |                        |                   |                   |                   |
|--------|-----------------------------------|---------------------------------------|-----------|-----------|------------------------|-------------------|-------------------|-------------------|
| Series | ries Type A(mm) B(mm) C(mm) D(mm) |                                       |           |           |                        |                   | F(mm)             | G(mm)             |
| FCB    | 1005                              | 1.0±0.10                              | 0.50±0.10 | 0.50±0.10 | 0.25±0.10              | 0.50              | 0.40              | 0.60              |
| FCM    | 1608                              | 1.6±0.15                              | 0.80±0.15 | 0.80±0.15 | 0.30±0.20              | 0.80              | 0.85              | 0.95              |
| HCB    | 2012                              | 2.0±0.20                              | 1.25±0.20 | 0.85±0.20 | 0.50±0.30              | 1.05              | 1.00              | 1.45              |
| GHB    | 2012                              | 2.0±0.20                              | 1.25±0.20 | 1.25±0.20 | 0.50±0.30              | 1.05              | 1.00              | 1.45              |
| FCI    | <mark>3216</mark>                 | 3.2±0.20                              | 1.60±0.20 | 1.10±0.20 | <mark>0.50±0.30</mark> | <mark>1.05</mark> | <mark>2.20</mark> | <mark>1.80</mark> |
| FHI    | 3225                              | 3.2±0.20                              | 2.50±0.20 | 1.30±0.20 | 0.50±0.30              | 1.05              | 2.20              | 2.70              |
| FCH    | 4516                              | 4.5±0.20                              | 1.60±0.20 | 1.60±0.20 | 0.50±0.30              | 1.05              | 3.30              | 1.80              |
| HCI    | 4532                              | 4.5±0.20                              | 3.20±0.20 | 1.50±0.20 | 0.50±0.30              | 1.05              | 3.30              | 3.40              |



∠∠∠Land ⊗⊗Solder Resist



PC board should be designed so that products can prevent damage from mechanical stress when warping the board.

#### 6-2. Soldering

Mildly activated rosin fluxes are preferred. TAI-TECH terminations are suitable for re-flow soldering systems. If hand soldering cannot be avoided, the preferred technique is the utilization of hot air soldering tools.

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#### 6-2.1 Soldering Reflow:

Recommended temperature profiles for lead free re-flow soldering in Figure 1. Table 1.1&1.2 (J-STD-020E)

#### 6-2.2 Soldering Iron:

Products attachment with a soldering iron is discouraged due to the inherent process control limitations. In the event that a soldering iron must be employed the following precautions are recommended. (Figure 2.)

• Preheat circuit and products to 150℃

• 350°C tip temperature (max)

- Never contact the ceramic with the iron tip1.0mm tip diameter (max)
- Use a 20 watt soldering iron with tip diameter of 1.0mm
- Limit soldering time to 4~5sec.

Fig.1 Soldering Reflow

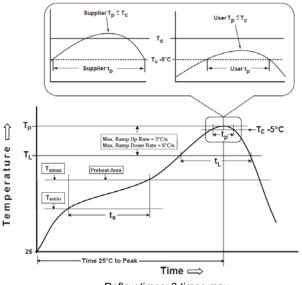
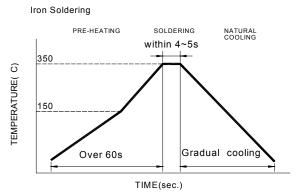


Fig.2 Iron Reflow



Iron Soldering times: 1 times max

Reflow times: 3 times max

Table (1.1): Reflow Profiles

| Profile Type:                                                                                                                                         | Pb-Free Assembly                |
|-------------------------------------------------------------------------------------------------------------------------------------------------------|---------------------------------|
| Preheat -Temperature Min(T <sub>smin</sub> ) -Temperature Max(T <sub>smax</sub> ) -Time(t <sub>s</sub> )from(T <sub>smin</sub> to T <sub>smax</sub> ) | 150°C<br>200°C<br>60-120seconds |
| Ramp-up rate(T <sub>L</sub> to T <sub>p</sub> )                                                                                                       | 3°C/second max.                 |
| $\label{eq:Liquidus} \begin{array}{c} \text{Liquidus temperature}(T_L) \\ \text{Time}(t_L) \\ \text{maintained above } T_L \\ \end{array}$            | 217℃<br>60-150 seconds          |
| Classification temperature(T <sub>c</sub> )                                                                                                           | See Table (1.2)                 |
| $\label{eq:top-point} \mbox{Time}(t_p) \mbox{ at Tc-} \mbox{ 5^{\circ}\!\!\!\!\!\!\!\!\!\!\!\!\!\!\!\!\!\!\!\!\!\!\!\!\!\!\!\!\!\!\!\!\!\!\!\!$       | < 30 seconds                    |
| Ramp-down rate(T <sub>p</sub> to T <sub>L</sub> )                                                                                                     | 6°C /second max.                |
| Time 25℃ to peak temperature                                                                                                                          | 8 minutes max.                  |

Tp: maximum peak package body temperature, Tc: the classification temperature.

For user (customer) **Tp** should be equal to or less than **Tc**.

Table (1.2) Package Thickness/Volume and Classification Temperature (Tc)

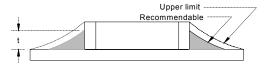
|                  | Package   | Volume mm <sup>3</sup> | Volume mm <sup>3</sup> | Volume mm <sup>3</sup> |
|------------------|-----------|------------------------|------------------------|------------------------|
|                  | Thickness | <350                   | 350-2000               | >2000                  |
|                  | <1.6mm    | 260°C                  | 260°C                  | 260°C                  |
| PB-Free Assembly | 1.6-2.5mm | 260°C                  | 250°C                  | 245°C                  |
|                  | ≥2.5mm    | 250°C                  | 245°C                  | 245°C                  |

Reflow is referred to standard IPC/JEDEC J-STD-020E •

#### 6-2.3 Solder Volume:

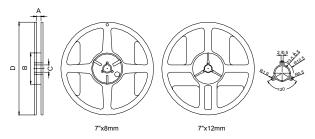
Accordingly increasing the solder volume, the mechanical stress to product is also increased. Exceeding solder volume may cause the failure of mechanical or electrical performance. Solder shall be used not to be exceed as shown in right side:

Minimum fillet height = soldering thickness + 25% product height



### 7.Packaging Information

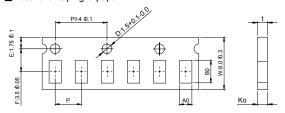
#### 7-1. Reel Dimension



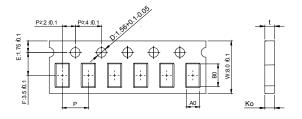
| Туре |                     | A(mm)    | B(mm)             | C(mm)                 | D(mm)              |  |
|------|---------------------|----------|-------------------|-----------------------|--------------------|--|
|      | <mark>7"x8mm</mark> | 9.0±0.5  | <mark>60±2</mark> | <mark>13.5±0.5</mark> | <mark>178±2</mark> |  |
|      | 7"x12mm             | 13.5±0.5 | 60±2              | 13.5±0.5              | 178±2              |  |

#### 7-2.1 Tape Dimension / 8mm

#### ■Material of taping is paper

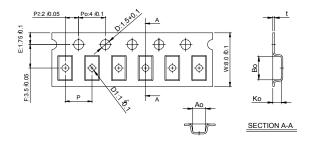


| Size  | ,  | Bo(mm)    | Ao(mm)    | Ko(mm)    | P(mm)    | t(mm)     |
|-------|----|-----------|-----------|-----------|----------|-----------|
| 10050 | 15 | 1.12±0.03 | 0.62±0.03 | 0.60±0.03 | 2.0±0.05 | 0.60±0.03 |



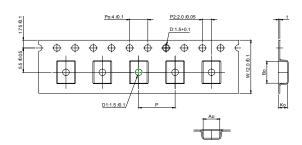
| Size   | Bo(mm)    | Ao(mm)          | Ko(mm)    | P(mm)    | t(mm)     |
|--------|-----------|-----------------|-----------|----------|-----------|
| 160808 | 1.80±0.05 | 0.96+0.05/-0.03 | 0.95±0.05 | 4.0±0.10 | 0.95±0.05 |
| 201209 | 2.10±0.05 | 1.30±0.05       | 0.95±0.05 | 4.0±0.10 | 0.95±0.05 |

#### ■Material of taping is plastic



| Size                | Bo(mm)    | Ao(mm)    | Ko(mm)    | P(mm)    | t(mm)     | D1(mm)   |
|---------------------|-----------|-----------|-----------|----------|-----------|----------|
| 201212              | 2.10±0.10 | 1.28±0.10 | 1.28±0.10 | 4.0±0.10 | 0.22±0.05 | 1.0±0.10 |
| <mark>321611</mark> | 3.35±0.10 | 1.75±0.10 | 1.25±0.10 | 4.0±0.10 | 0.23±0.05 | 1.0±0.10 |
| 322513              | 3.42±0.10 | 2.77±0.10 | 1.55±0.10 | 4.0±0.10 | 0.22±0.05 | 1.0±0.10 |
| 321609              | 3.40±0.10 | 1.77±0.10 | 1.04±0.10 | 4.0±0.10 | 0.22±0.05 | 1.0±0.10 |

#### 7-2.2 Tape Dimension / 12mm



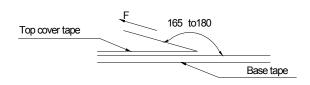
| Size   | Bo(mm)    | Ao(mm)    | Ko(mm)    | P(mm)    | t(mm)     | D1(mm)   |
|--------|-----------|-----------|-----------|----------|-----------|----------|
| 451616 | 4.70±0.10 | 1.75±0.10 | 1.75±0.10 | 4.0±0.10 | 0.24±0.05 | 1.5±0.10 |
| 453215 | 4.70±0.10 | 3.45±0.10 | 1.60±0.10 | 8.0±0.10 | 0.24±0.05 | 1.5±0.10 |

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#### 7-3. Packaging Quantity

| Chip Size   | 453215 | 451616 | 322513 | <mark>321611</mark> | 321609 | 201212 | 201209 | 160808 | 100505 |
|-------------|--------|--------|--------|---------------------|--------|--------|--------|--------|--------|
| Chip / Reel | 1000   | 2000   | 2500   | <mark>3000</mark>   | 3000   | 2000   | 4000   | 4000   | 10000  |
| Inner box   | 4000   | 8000   | 12500  | <mark>15000</mark>  | 15000  | 10000  | 20000  | 20000  | 50000  |
| Middle box  | 20000  | 40000  | 62500  | <mark>75000</mark>  | 75000  | 50000  | 100000 | 100000 | 250000 |
| Carton      | 40000  | 80000  | 125000 | <mark>150000</mark> | 150000 | 100000 | 200000 | 200000 | 500000 |

#### 7-4. Tearing Off Force



The force for tearing off cover tape is 15 to 60 grams in the arrow direction under the following conditions.

| Room Temp. | Room Humidity | Room atm | Tearing Speed |  |
|------------|---------------|----------|---------------|--|
| (℃)        | (%)           | (hPa)    | mm/min        |  |
| 5~35       | 45~85         | 860~1060 | 300           |  |

#### **Application Notice**

Storage Conditions(component level)

To maintain the solder ability of terminal electrodes:

- 1. TAI-TECH products meet IPC/JEDEC J-STD-020D standard-MSL, level 1.
- 3. Recommended products should be used within 12 months from the time of delivery.
- 4. The packaging material should be kept where no chlorine or sulfur exists in the air.
- Transportation
  - 1. Products should be handled with care to avoid damage or contamination from perspiration and skin oils.
  - 2. The use of tweezers or vacuum pick up is strongly recommended for individual components.
  - 3. Bulk handling should ensure that abrasion and mechanical shock are minimized.



# **Test Report**

號碼(No.): CE/2019/C0498 日期(Date): 2019/12/10 頁數(Page): 1 of 14

西北臺慶科技股份有限公司 / TAI-TECH ADVANCED ELECTRONICS CO., LTD.

(臺慶精密電子(昆山)有限公司 / TAI-TECH ADVANCED ELECTRONICS (KUN-SHAN) CO., LTD.)

(慶邦電子元器件(泗洪) 有限公司 / TAIPAQ ELECTRONICS (SI-HONG) CO., LTD.)

桃園市楊梅區幼獅工業區幼四路1號 (NO. 1, YOU 4TH ROAD, YOUTH INDUSTRIAL DISTRICT, YANG-MEI, TAO-YUAN CITY, TAIWAN, R. O. C.)

(江蘇省昆山市篷朗昆嘉高科技工業區郭澤路 / GUO-ZE ROAD, KUNJIA HI-TECH INDUSTRIAL PARK, KUN-SHAN, JIANG-SU, CHINA) (中國,江蘇省,宿遷市,泗洪縣,經濟開發區杭州路南側,建設北路東側 / THE SOUTH HANGZHOU ROAD AND THE EAST JIANSHE ROAD, ECONOMIC DEVELOPMENT ZONE, SIHONG COUNTY, SUQIANCITY, JIANGSU PROVINCE, P. R., CHINA)

以下測試樣品係由申請廠商所提供及確認 (The following sample(s) was/were submitted and identified by/on behalf of the applicant as):

樣品名稱(Sample Description)

FERRITE CHIP BEAD · FERRITE CHIP INDUCTOR · ARRAY · MCF · MCM · YMV · APM SERIES

樣品型號(Style/Item No.)

FERRITE CHIP BEAD · FERRITE CHIP INDUCTOR · ARRAY · MCF · MCM · YMV · APM SERIES

收件日期(Sample Receiving Date)

2019/12/04

測試期間(Testing Period)

2019/12/04 to 2019/12/10

測試結果(Test Results) : 請參閱下一頁 (Please refer to following pages).

Troy Chang / Manager - Vec Signed for and behalf of SĞS TAIWAN LTD.

Chemical Laboratory - Taipei

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25, Wu Chyuan 7th Road, New Taipei Industrial Park, Wu Ku District, New Taipei City, Taiwan /斯士市五股區新北麻業園區五權七路25號 SGS Faiwan Ltd. 台灣接種科技股份有限公司 25, Wu Cityuan rin Hosel, New Yaipes Imuusikai rain, 1997 (2018) 14-886 (02):2299 3939 (74-886 (02):2299 3939 (74-886 (02):2299 3939 (74-886 (02):2299 3939 (74-886 (02):2299 3939 (74-886 (02):2299 3939 (74-886 (02):2299 3939 (74-886 (02):2299 3939 (74-886 (02):2299 3939 (74-886 (02):2299 3939 (74-886 (02):2299 3939 (74-886 (02):2299 3939 (74-886 (02):2299 3939 (74-886 (02):2299 3939 (74-886 (02):2299 3939 (74-886 (02):2299 3939 (74-886 (02):2299 3939 (74-886 (02):2299 3939 (74-886 (02):2299 3939 (74-886 (02):2299 3939 (74-886 (02):2299 3939 (74-886 (02):2299 3939 (74-886 (02):2299 3939 (74-886 (02):2299 3939 (74-886 (02):2299 3939 (74-886 (02):2299 3939 (74-886 (02):2299 3939 (74-886 (02):2299 3939 (74-886 (02):2299 3939 (74-886 (02):2299 3939 (74-886 (02):2299 3939 (74-886 (02):2299 3939 (74-886 (02):2299 3939 (74-886 (02):2299 3939 (74-886 (02):2299 3939 (74-886 (02):2299 3939 (74-886 (02):2299 3939 (74-886 (02):2299 3939 (74-886 (02):2299 3939 (74-886 (02):2299 3939 (74-886 (02):2299 3939 (74-886 (02):2299 3939 (74-886 (02):2299 3939 (74-886 (02):2299 3939 (74-886 (02):2299 3939 (74-886 (02):2299 3939 (74-886 (02):2299 3939 (74-886 (02):2299 3939 (74-886 (02):2299 3939 (74-886 (02):2299 3939 (74-886 (02):2299 3939 (74-886 (02):2299 3939 (74-886 (02):2299 3939 (74-886 (02):2299 3939 (74-886 (02):2299 3939 (74-886 (02):2299 3939 (74-886 (02):2299 3939 (74-886 (02):2299 3939 (74-886 (02):2299 3939 (74-886 (02):2299 3939 (74-886 (02):2299 3939 (74-886 (02):2299 3939 (74-886 (02):2299 3939 (74-886 (02):2299 (74-886 (02):2299 (74-886 (02):2299 (74-886 (02):2299 (74-886 (02):2299 (74-886 (02):2299 (74-886 (02):2299 (74-886 (02):2299 (74-886 (02):2299 (74-886 (02):2299 (74-886 (02):2299 (74-886 (02):2299 (74-886 (02):2299 (74-886 (02):2299 (74-886 (02):2299 (74-886 (02):2299 (74-886 (02):2299 (74-886 (02):2299 (74-886 (02):2299 (74-886 (02):2299 (74-886 (02):2299 (74-886 (02):2299 (74-886 (02):2299 (74-886 (02):2299 (74-886 (02):2299 (74-886 (02):2299 (74-886 (02):2299 (74-886 (02):2299



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西北臺慶科技股份有限公司 / TAI-TECH ADVANCED ELECTRONICS CO., LTD.

(臺廣精密電子(昆山)有限公司 / TAI-TECH ADVANCED ELECTRONICS (KUN-SHAN) CO., LTD.)

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#### 測試結果(Test Results)

測試部位(PART NAME)No.1

: 整體混測 (MIXED ALL PARTS)

| 測試項目<br>(Test Items)                                                 | 單位<br>(Unit) | 測試方法<br>(Method)                                                                                                                  | MDL | 結果<br>(Result)<br>No.1 |
|----------------------------------------------------------------------|--------------|-----------------------------------------------------------------------------------------------------------------------------------|-----|------------------------|
| 鎘 / Cadmium (Cd)                                                     | mg/kg        | 參考IEC 62321-5 (2013),以感應耦合電<br>浆發射光譜儀檢測. / With reference                                                                         | 2   | n. d.                  |
| 鉛 / Lead (Pb)                                                        | mg/kg        | to IEC 62321-5 (2013) and performed by ICP-0ES.                                                                                   | 2   | n. d.                  |
| 汞 / Mercury (Hg)                                                     | mg/kg        | 参考IEC 62321-4:2013+ AMD1:2017,以<br>感應耦合電漿發射光譜儀檢測. / With<br>reference to IEC 62321-4:2013+<br>AMD1:2017 and performed by ICP-OES. | 2   | n. d.                  |
| 六價络 / Hexavalent Chromium Cr(VI)                                     | mg/kg        | 参考IEC 62321-7-2 (2017),以UV-VIS檢<br>測. / With reference to IEC 62321-7-<br>2 (2017) and performed by UV-VIS.                       | 8   | n. d.                  |
| 多溴聯苯總和 / Sum of PBBs                                                 | mg/kg        |                                                                                                                                   | _   | n. d.                  |
| 一溴聯苯 / Monobromobiphenyl                                             | mg/kg        |                                                                                                                                   | 5   | n. d.                  |
| - 溴聯苯 / Dibromobiphenyl mg/kg                                        |              |                                                                                                                                   | 5   | n. d.                  |
| 三溴聯苯 / Tribromobiphenyl                                              | mg/kg        | 参考IEC 62321-6 (2015),以氣相層析/<br>質譜儀檢測. / With reference to IEC<br>62321-6 (2015) and performed by<br>GC/MS.                        | 5   | n. d.                  |
| 四溴聯苯 / Tetrabromobiphenyl                                            | mg/kg        |                                                                                                                                   | 5   | n. d.                  |
| 五溴聯苯 / Pentabromobiphenyl                                            | mg/kg        |                                                                                                                                   | 5   | n. d.                  |
| 六溴聯苯 / Hexabromobiphenyl                                             | mg/kg        |                                                                                                                                   | 5   | n. d.                  |
| t 溴聯苯 / Heptabromobiphenyl mg/kg<br>  、溴聯苯 / Octabromobiphenyl mg/kg |              | - UC/ MG.                                                                                                                         | 5   | n, d,                  |
|                                                                      |              |                                                                                                                                   | 5   | n. d.                  |
| 九溴聯苯 / Nonabromobiphenyl                                             | mg/kg        | ] Γ                                                                                                                               | 5   | n. d.                  |
| 十溴聯苯 / Decabromobiphenyl                                             | mg/kg        |                                                                                                                                   | 5   | n. d.                  |

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**Test Report** 

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西北臺慶科技股份有限公司 / TAI-TECH ADVANCED ELECTRONICS CO., LTD.

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| 測試項目<br>(Test Items)                                                                                                                                                                                                              | 單位<br>(Unit) | 测試方法<br>(Method)                                                                                               | MDL          | 結果<br>(Result)<br>No.1 |
|-----------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|--------------|----------------------------------------------------------------------------------------------------------------|--------------|------------------------|
| 多溴聯苯醚總和 / Sum of PBDEs                                                                                                                                                                                                            | mg/kg        |                                                                                                                | <del>-</del> | n. d.                  |
| 一溴聯苯醚 / Monobromodiphenyl ether                                                                                                                                                                                                   | mg/kg        |                                                                                                                | 5            | n. d.                  |
| 二溴聯苯醚 / Dibromodiphenyl ether                                                                                                                                                                                                     | mg/kg        |                                                                                                                | 5            | n. d.                  |
| 三溴聯苯醚 / Tribromodiphenyl ether                                                                                                                                                                                                    |              | A N.TTO 00001 0 (0015)                                                                                         | 5            | n. d.                  |
| 四溴聯苯醚 / Tetrabromodiphenyl ether                                                                                                                                                                                                  | mg/kg        | 參考IEC 62321-6 (2015),以氣相層析/                                                                                    | 5            | n. d.                  |
| 五溴聯苯醚 / Pentabromodiphenyl ether                                                                                                                                                                                                  | mg/kg        | 質譜儀檢測. / With reference to IEC<br>62321-6 (2015) and performed by                                              | 5            | n. d.                  |
| 六溴聯苯醚 / Hexabromodiphenyl ether                                                                                                                                                                                                   | mg/kg        | GC/MS.                                                                                                         | 5            | n, d.                  |
| 七溴聯苯醚 / Heptabromodiphenyl ether                                                                                                                                                                                                  | mg/kg        | 007 MO,                                                                                                        | 5            | n. d.                  |
| 八溴聯苯醚 / Octabromodiphenyl ether                                                                                                                                                                                                   | mg/kg        |                                                                                                                | 5            | n. d.                  |
| 九溴聯苯醚 / Nonabromodiphenyl ether                                                                                                                                                                                                   | mg/kg        |                                                                                                                | 5            | n. d.                  |
| 十溴聯苯醚 / Decabromodiphenyl ether                                                                                                                                                                                                   | mg/kg        |                                                                                                                | 5            | n. d.                  |
| 六溴環十二烷及所有主要被辨別出的異構物 / Hexabromocyclododecane (HBCDD) and all major diastereoisomers identified ( $\alpha$ - HBCDD, $\beta$ - HBCDD, $\gamma$ - HBCDD) (CAS No.: 25637-99-4 and 3194-55-6 (134237-51-7, 134237-50-6, 134237-52-8)) | mg/kg        | 參考IEC 62321 (2008),以氣相層析/質譜儀檢測. / With reference to IEC 62321 (2008). Analysis was performed by GC/MS.         | 5            | n. d.                  |
| 鹵素 / Halogen                                                                                                                                                                                                                      |              |                                                                                                                |              |                        |
| 鹵素 (氟) / Halogen-Fluorine (F)<br>(CAS No.: 14762-94-8)                                                                                                                                                                            | mg/kg        |                                                                                                                | 50           | n. d.                  |
| 鹵素 (氣) / Halogen-Chlorine (C1) mg/kg (CAS No.: 22537-15-1) mg/kg (As No.: 10097-32-2) mg/kg (CAS No.: 14362-44-8) mg/kg                                                                                                           |              | 参考BS EN 14582 (2016),以離子層析儀<br>分析. / With reference to BS EN<br>14582 (2016). Analysis was performed<br>by IC. | 50           | n. d.                  |
|                                                                                                                                                                                                                                   |              |                                                                                                                | 50           | n. d.                  |
|                                                                                                                                                                                                                                   |              |                                                                                                                | 50           | n. d.                  |

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**Test Report** 

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| 測試項目<br>(Test Items)                                                               | 單位<br>(Unit) | 測試方法<br>(Method)                                                                                                     | MDL | 結果<br>(Result)<br>No.1 |
|------------------------------------------------------------------------------------|--------------|----------------------------------------------------------------------------------------------------------------------|-----|------------------------|
| 鄰苯二甲酸丁苯甲酯 / BBP (Butyl<br>Benzyl phthalate) (CAS No.: 85-68-7)                     | mg/kg        |                                                                                                                      | 50  | n. d.                  |
| 鄰苯二甲酸二丁酯 / DBP (Dibutyl phthalate) (CAS No.: 84-74-2)                              | mg/kg        |                                                                                                                      | 50  | n. d.                  |
| 鄭苯二甲酸二 (2-乙基己基)酯 / DEHP<br>(Di- (2-ethylhexyl) phthalate) (CAS<br>No.: 117-81-7)   | mg/kg        |                                                                                                                      | 50  | n. d.                  |
| 鄰苯二甲酸二異丁酯 / DIBP (Di-isobutyl phthalate) (CAS No.: 84-69-5)                        | mg/kg        |                                                                                                                      | 50  | n. d.                  |
| 鄰苯二甲酸二異癸酯 / DIDP (Di-<br>isodecyl phthalate) (CAS No.: 26761-<br>40-0; 68515-49-1) | mg/kg        | mg/kg       參考IEC 62321-8 (2017),以氣相層析/質譜儀檢測./With reference to IEC 62321-8 (2017). Analysis was performed by GC/MS. |     | n. d.                  |
| 鄰苯二甲酸二異壬酯 / DINP (Di-<br>isononyl phthalate) (CAS No.: 28553-<br>12-0; 68515-48-0) | mg/kg        | performed by Ge/ms.                                                                                                  | 50  | n. d.                  |
| 鄰苯二甲酸二正辛酯 / DNOP (Di-n-octyl phthalate) (CAS No.: 117-84-0)                        | mg/kg        |                                                                                                                      | 50  | n. d.                  |
| 鄭苯二甲酸二正己酯 / DNHP (Di-n-hexyl phthalate) (CAS No.: 84-75-3)                         | mg/kg        |                                                                                                                      | 50  | n. d.                  |
| 鄰苯二甲酸二戊酯 / DNPP (Di-n-pentyl phthalate) (CAS No.: 131-18-0)                        | mg/kg        |                                                                                                                      | 50  | n. d.                  |
| 全氟辛烷磺酸 / Perfluorooctane<br>sulfonates (PFOS-Acid, Metal Salt,<br>Amide)           | mg/kg        | 参考US EPA 3550C (2007),以液相層析/<br>質譜儀檢測. / With reference to US<br>EPA 3550C (2007). Analysis was                      | 10  | n. d.                  |
| 全氟辛酸 / PFOA (CAS No.: 335-67-1)                                                    | mg/kg        | performed by LC/MS.                                                                                                  | 10  | n. d.                  |

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西北臺慶科技股份有限公司 / TAI-TECH ADVANCED ELECTRONICS CO., LTD.

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| 測試項目<br>(Test Items)            | 單位<br>(Unit) | 测試方法<br>(Method)                                                      | MDL          | 結果<br>(Result)<br>No.1 |
|---------------------------------|--------------|-----------------------------------------------------------------------|--------------|------------------------|
| 绨 / Antimony (Sb)               | mg/kg        | 参考US EPA 3052 (1996),以感應耦合電                                           | 2            | n. d.                  |
| 鈹 / Beryllium (Be)              | mg/kg        | 漿發射光譜儀檢測. / With reference<br>  to US EPA 3052 (1996). Analysis was   | 2            | n. d.                  |
| 神 / Arsenic (As)                | mg/kg        | performed by ICP-OES.                                                 | 2            | n. d.                  |
| 聚氯乙烯 / Polyvinyl chloride (PVC) | **           | 以紅外光譜分析及焰色法檢測. /<br>Analysis was performed by FTIR and<br>FLAME Test. | <del>-</del> | Negative               |

#### 備註(Note):

- 1. mg/kg = ppm : 0.1wt% = 1000ppm
- 2. MDL = Method Detection Limit (方法偵測極限值)
- 3. n.d. = Not Detected (未檢出)
- 4. "-" = Not Regulated (無規格值)
- 5. \*\*= Qualitative analysis (No Unit) 定性分析(無單位)
- 6. Negative = Undetectable 陰性(未偵測到); Positive = Detectable 陽性(已偵測到)
- 7. 樣品的測試是基於申請人要求混合測試,報告中的混合測試結果不代表其中個別單一材質的含量。(The samples was/were analyzed on behalf of the applicant as mixing sample in one testing. The above results was/were only given as the informality value.)

#### PFOS參考資訊(Reference Information): 持久性有機污染物 POPs - (EU) 2019/1021

PFOS濃度在物質或製備中不得超過0,001%(10ppm),在半成品、成品或零部件中不得超過0.1%(1000ppm),在紡織品或 塗層材料中不得超過lμg/m²。

(Outlawing PFOS as substances or preparations in concentrations above 0.001% (10ppm), in semi-finished products or articles or parts at a level above 0.1%(1000ppm), in textiles or other coated materials above lug/m<sup>2</sup>.)

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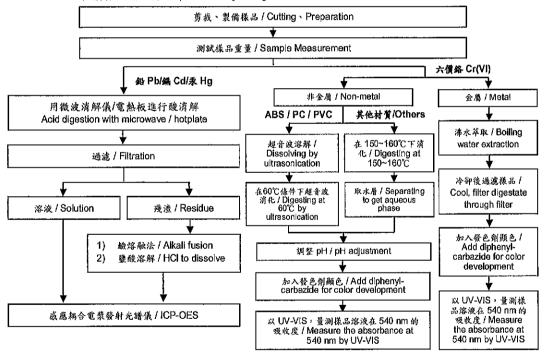
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#### 重金屬流程圈 / Analytical flow chart of Heavy Metal

根據以下的流程圖之條件,樣品已完全溶解。(六價鉻測試方法除外)

These samples were dissolved totally by pre-conditioning method according to below flow chart. (Cr8+ test method excluded)

- 測試人員: 陳恩臻 / Technician ; Rita Chen
- 測試負責人:張啟興 / Supervisor: Troy Chang



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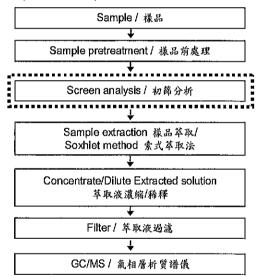
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#### 多溴聯苯/多溴聯苯醚分析流程圖 / Analytical flow chart - PBB/PBDE

- 测试人員:涂雅苓 / Technician: Yaling Tu
- 測試負責人:張啟興 / Supervisor: Troy Chang

初央测试程序 / First testing process -確認程序 / Confirmation process - - - →



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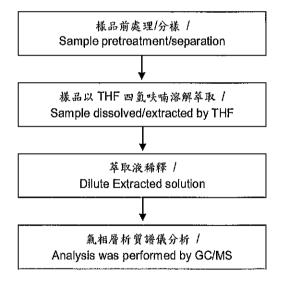
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#### 可塑劑分析流程圖 / Analytical flow chart - Phthalate

測試人員:涂雅苓 / Technician: Yaling Tu

測試負責人:張啟興 / Supervisor: Troy Chang

【测試方法/Test method: IEC 62321-8】



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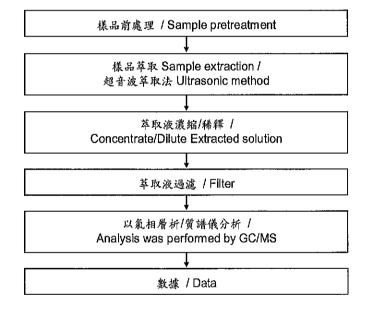
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#### 六溴環十二烷分析流程圖 / Analytical flow chart - HBCDD

- 測試人員:涂雅苓 / Technician: Yaling Tu
- 測試負責人:張啟與 / Supervisor: Troy Chang



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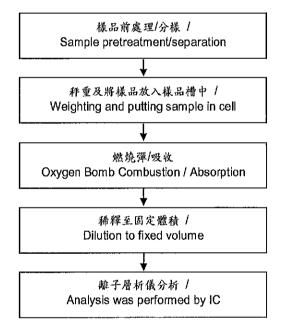
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#### 鹵素分析流程圖 / Analytical flow chart - Halogen

測試人員: 陳恩臻 / Technician: Rita Chen

測試負責人:張啟與 / Supervisor: Troy Chang



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西北臺廣科技股份有限公司 / TAI-TECH ADVANCED ELECTRONICS CO., LTD.

(臺慶精密電子(昆山)有限公司 / TAI-TECH ADVANCED ELECTRONICS (KUN-SHAN) CO., LTD.)

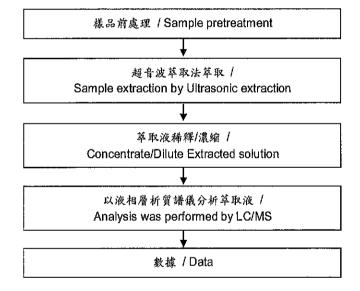
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#### 全氟辛酸/全氟辛烷磺酸分析流程圖 / Analytical flow chart - PFOA/PFOS

- 測試人員:涂雅苓 / Technician: Yaling Tu
- 測試負責人:張啟興 / Supervisor: Troy Chang



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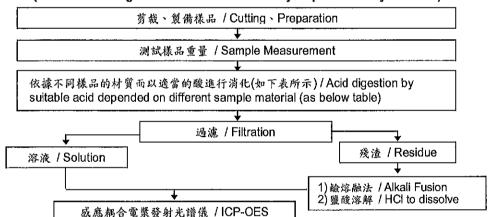
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> 根據以下的流程圖之條件,樣品已完全溶解。 / These samples were dissolved totally by pre-conditioning method according to below flow chart.

- 測試人員:陳恩臻 / Technician: Rita Chen
- 測試負責人:張啟興 / Supervisor: Troy Chang

#### 元素以 ICP-OES 分析的消化流程圈 (Flow Chart of digestion for the elements analysis performed by ICP-OES)



| 鲄,銄,鉊,焊錫 / Steel, copper, aluminum, solder    | 王水,硝酸,鹽酸,氫氟酸,雙氧水 /<br>Aqua regia, HNO3, HCI, HF, H <sub>2</sub> O <sub>2</sub> |
|-----------------------------------------------|--------------------------------------------------------------------------------|
| 玻璃 / Glass                                    | 硝酸,氫氟酸 / HNO3/HF                                                               |
| 金,鉑,鈀,陶瓷 / Gold, platinum, palladium, ceramic | 王水 / Aqua regia                                                                |
| 銀 / Silver                                    | 硝酸 / HNO <sub>3</sub>                                                          |
| 塑膠 / Plastic                                  | 硫酸,雙氧水,硝酸,鹽酸 / H2SO4, H2O2, HNO3, HCI                                          |
| 其他 / Others                                   | 加入適當的試劑至完全溶解 / Added appropriate reagent to total digestion                    |

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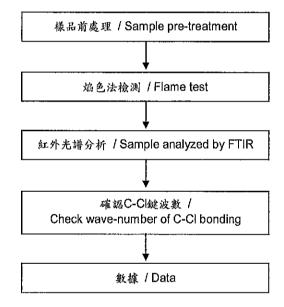
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#### 聚氯乙烯物質判定分析流程圖 / Analysis flow chart - PVC

- 测試人員:涂雅苓 / Technician: Yaling Tu
- 測試負責人:張啟興 / Supervisor: Troy Chang



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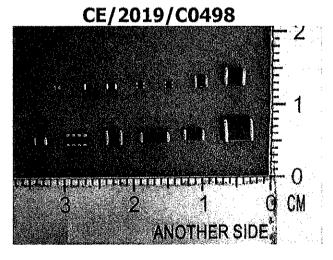
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#### \* 照片中如有箭頭標示,則表示為實際檢測之樣品/部位. \*

(The tested sample / part is marked by an arrow if it's shown on the photo.)

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